Search Notes				
		 		

Application/Control No.	Applicant(s)/Patent under Reexamination	•
09/869,475	MORISHITA ET AL.	
Examiner	Art Unit	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
DIALOG (Medline, Embase, Biosis; see attached serach notes)	11/30/2006	QN
WEST (see attached search notes)	11/30/2006	QN
Inventor's name search	11/30/2006	QN
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